Search Notes				

Applic	cation/Control No.	Applicant(s Reexaminat)/Patent under ion
10/71	5,403	MATSUO E	ET AL.
Exam	iner	Art Unit	
Edna	Wong	1753	

SEARCHED			
Class	Subclass	Date	Examiner
205	43	4/7/2005	EW
205	45	4/7/2005	EW
205	46	4/7/2005	EW
205	173	4/7/2005	EW
205	174	4/7/2005	EW
205	229	4/7/2005	EW
205	324	4/7/2005	EW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Search	4/7/2005	EW	
EAST	4/7/2005	EW	
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